

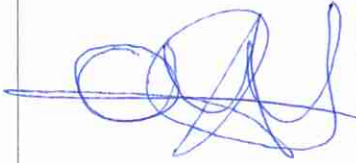


# Test Report Summary

## No E-15-I-076-FL

### PRIME Certification Tests Cases for Service Nodes

<b>EQUIPMENT UNDER TEST</b>	Single-phase service node (chip)
<b>MODEL/FW VERSION</b>	ET-D809508J50-0002 / v0310
<b>CERTIFICATION SCOPE<sup>1</sup></b>	PHY and MAC layers
<b>MANUFACTURER</b>	Renesas Electronics Europe Ltd
<b>APPLICANT</b>	Kevin Jones Dukes Meadow, Bourne End, Buckinghamshire, SL8 5FH, UK
<b>DATE OF RECEPTION</b>	April 27 <sup>th</sup> , 2105
<b>PRIME SPECIFICATION VERSION/TEST CASE VERSION</b>	PRIME-Specification V1.3.6 / PRIME Certification SN Tests Cases R1.3
<b>DATE OF EXECUTION</b>	From 27 till 29 April 2015
<b>DATE OF ISSUE OF REPORT</b>	Brussels, May 20 <sup>th</sup> , 2015

Responsible for tests	Head of Laboratory	PRIME Alliance Vice President
		
Fernando Lobo	Elena Henríquez	Oscar Márquez

- \* This test report summary is granted on account of tests made at location of DET NORSKE VERITAS ESPAÑA SL.in Madrid, Spain.
- \* The results of the present report apply only to the samples tested and the moment and conditions under which the measurements were performed.
- \* The complete results, including remarks and limitations, are laid down in our complete test report no. E-15-I-075-FL which can be obtained at DET NORSKE VERITAS ESPAÑA SL.. The certificate and the test report are indivisible.
- \* The test report summary is issued by PRIME Alliance. It shall not be reproduced, in total or in part and in whatever way, without written permission of DET NORSKE VERITAS ESPAÑA SL.

<sup>1</sup> IMPORTANT: Remarks apply to the implementation of this function. See complete test report no. E-15-I-FL-075 (ANNEX I) for full details